10/553200 JC09 Rec'd PCT/PTQ_13 00T 2005

Form PTO 1449 U.S. DEPARTMENT OF COMMERCE (Modified) PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. : 279492US0PCT .		SERIAL NO. New U.S. PCT Application Based on PCT/JP04/05332						
				APPLICANT Based on 1 C173F 04/03532							
LIST OF	REFE	RENCES CITED BY AF	PLICANT	Seigo WATANABE, et al.							
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	CLASS SUB FILING DATE IF APPROPRIATE					
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CNN	AN	2003-64042	03/05/03	JP				NO			
	AO	2003-64043	03/05/03	JP				NO			
	AP	2003-71283	03/11/03	JP				NO			
	AQ	63-295546	12/01/88	JP(Equivalent of US 4,769,355)				NO			
	AR	61-13701	04/15/86	JP(Equivalent of JP 58-113163)			\neg	NO			
	AS	59-204163	11/19/84	JP(with English abstract)				NO			
\ /	AT	01-228950	09/12/89	JP(with English abstract)				NO			
V	AU	10-043595	02/17/98	JP(with English abstract)				NO			
CNN	AV	3-217794	09/25/91	JP(Equivalent of WO 97/33863)				NO			
		OTHER R	EFERENCES (Including Author, Title, Date, Pertinent	Pages, e	tc.)					
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Examiner	/	Cam Nguyen/ Date Considered 09/25/2006									
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